

Search Notes

Application/Control No.

10/645,249

Examiner

Justin Krause

Applicant(s)/Patent under
Reexamination

TAKAHASHI ET AL.

Art Unit

3682

SEARCHED

Class	Subclass	Date	Examiner
Update	Above	1/20/2007	JMK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR